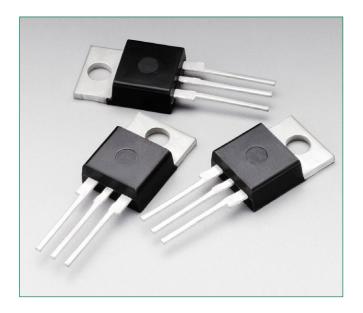
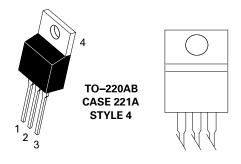
# BTA16-600BW3G, BTA16-800BW3G,

**Thyristors** 





#### **Pin Out**



### **Description**

Designed for high performance full-wave ac control applications where high noise immunity and high commutating di/dt are required.

#### **Features**

- Blocking Voltage to 800 V
- On-State Current Rating of 16 A RMS at 80°C Uniform Gate Trigger Currents in Three Quadrants
- High Immunity to dV/dt 1500 V/µs minimum at 125°C
- Minimizes Snubber Networks for Protection
- Industry Standard TO-220AB Package
- High Commutating dl/dt 4.0 A/ms minimum at 125°C
- Internally Isolated (2500 V<sub>BMS</sub>)
- These Devices are Pb-Free

### **Functional Diagram**



## **Additional Information**







Samples



# Maximum Ratings (T<sub>1</sub> = 25°C unless otherwise noted)

**Thyristors** 

- 3				
Rating	Symbol	Value	Unit	
Peak Repetitive Off-State Voltage (Note 1) (Gate Open, Sine Wave 50 to 60 Hz, $T_J = -40^{\circ}$ to 125°C)	BTA16-600BW3G BTA16-800BW3G	V <sub>DRM</sub> , V <sub>RRM</sub>	600 800	V
On-State RMS Current (Full Cycle Sine Wave, 60 Hz, T <sub>C</sub> = 80°C)		I <sub>T (RMS)</sub>	16	А
Peak Non-Repetitive Surge Current (One Full Cycle Sine Wave, 60 Hz, T <sub>c</sub> = 25°C)		I <sub>TSM</sub>	170	А
Circuit Fusing Consideration (t = 8.3 ms)		l²t	120	A²sec
Non-Repetitive Surge Peak Off-State Voltage ( $T_J = 25^{\circ}\text{C}$ , t = 10ms)		V <sub>DSM</sub> /V <sub>RSM</sub>	V <sub>DSM</sub> /V <sub>RSM</sub> +100	V
Peak Gate Current ( $T_J = 125$ °C, t = 20ms)		I <sub>GM</sub>	4.0	А
Peak Gate Power (Pulse Width ≤ 1.0 μs, T <sub>C</sub> = 80°C)		P <sub>G(AV)</sub>	20	W
Average Gate Power (T <sub>J</sub> = 125°C)		P <sub>G(AV)</sub>	1.0	W
Operating Junction Temperature Range		$T_{J}$	-40 to +125	°C
Storage Temperature Range		T <sub>stg</sub>	-40 to +125	°C
RMS Isolation Voltage (t = 300 ms, R.H. $\leq$ 30%, T <sub>A</sub> = 25°C)		V <sub>iso</sub>	2500	V

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied.

### **Thermal Characteristics**

	Rating	Symbol	Value	Unit
Thermal Resistance,	Junction-to-Case (AC) Junction-to-Ambient	R <sub>ejc</sub> R <sub>eja</sub>	2.5 60	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds		T <sub>L</sub>	260	°C

Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. V<sub>DRM</sub> and V<sub>RRM</sub> for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.



## **Electrical Characteristics** · **OFF** (T<sub>1</sub> = 25°C unless otherwise noted; Electricals apply in both directions)

Characteristic		Symbol	Min	Тур	Max	Unit
Peak Repetitive Blocking Current	T, = 25°C	I <sub>DRM</sub> ,	-	-	0.005	m ^
$(V_D = V_{DRM} = V_{RRM}; Gate Open)$	T <sub>J</sub> = 125°C	IRRM	-	-	2.0	mA

## **Electrical Characteristics** - **ON** $(T_y = 25^{\circ}\text{C unless otherwise noted; Electricals apply in both directions)$

Characteristic		Symbol	Min	Тур	Max	Unit
Forward On-State Voltage (Note 2) ( $I_{TM} = \pm 22.5 \text{ A Peak}$ )	'	$V_{TM}$	-	-	1.55	V
	MT2(+), G(+)		2.5	_	50	mA
Gate Trigger Current (Continuous dc) ( $V_D = 12 \text{ V}, R_L = 30 \Omega$ )	MT2(+), G(-)	I <sub>GT</sub>	2.5	_	50	
	MT2(-), G(-)		2.5	_	50	
Holding Current (V <sub>D</sub> = 12 V, Gate Open, Initiating Current = ±150 mA)		I <sub>H</sub>	-	_	60	mA
	MT2(+), G(+)		-	_	70	mA
Latching Current ( $V_D = 12 \text{ V}, I_G = 50 \text{ mA}$ )	MT2(+), G(-)	l <sub>L</sub>	-	-	90	
	MT2(-), G(-)		-	_	70	
	MT2(+), G(+)	V <sub>GT</sub>	0.5	_	1.7	V
Gate Trigger Voltage ( $V_D = 12 \text{ V}, R_L = 30 \Omega$ )	MT2(+), G(-)		0.5	-	1.1	
	MT2(-), G(-)		0.5	-	1.1	
	MT2(+), G(+)		0.2	-	-	
Gate Non-Trigger Voltage (T <sub>J</sub> = 125°C)	MT2(+), G(-)	t <sub>gt</sub>	0.2	_	_	V
	MT2(-), G(-)		0.2	_	-	

<sup>2.</sup> Indicates Pulse Test: Pulse Width  $\leq$  2.0 ms, Duty Cycle  $\leq$  2%.



# **Dynamic Characteristics**

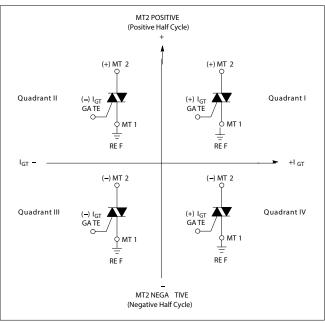
Characteristic	Symbol	Min	Тур	Max	Unit
Rate of Change of Commutating Current, See Figure 10. (Gate Open, $T_J = 125$ °C, No Snubber)	(dl/dt)c	4.0	-	_	A/ms
Critical Rate of Rise of On–State Current ( $T_J = 125^{\circ}\text{C}$ , $f = 120$ Hz, $I_G = 2 \times I_{gT'}$ tr $\leq 100$ ns)	dl/dt	-	_	50	A/µs
Critical Rate of Rise of Off-State Voltage ( $V_D = 0.66 \times V_{DRM}$ , Exponential Waveform, Gate Open, $T_J = 125^{\circ}$ C)	dV/dt	1500	_	_	V/µs

**Thyristors** 

## **Voltage Current Characteristic of SCR**

Symbol	Parameter		
$V_{DRM}$	Peak Repetitive Forward Off State Voltage		
I <sub>DRM</sub>	Peak Forward Blocking Current		
V <sub>RRM</sub>	Peak Repetitive Reverse Off State Voltage		
I <sub>RRM</sub>	Peak Reverse Blocking Current		
V <sub>TM</sub>	Maximum On State Voltage		
I <sub>H</sub>	Holding Current		

### **Quadrant Definitions for a Triac**



All polarities are referenced to MT1.
With in—phase signals (using standard AC lines) quadrants I and III are used

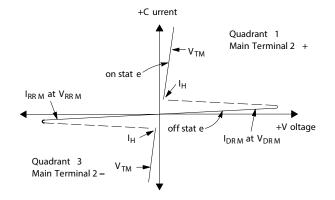
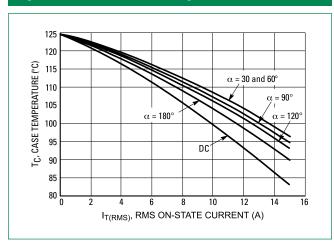


Figure 2. On-State Power Dissipation

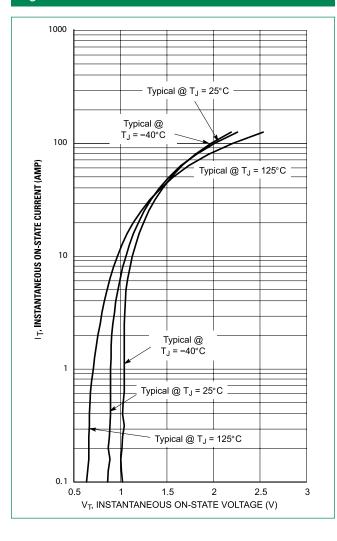
## **Figure 1. RMS Current Derating**



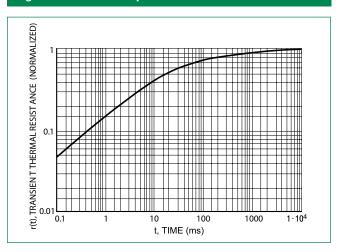
**Thyristors** 

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Figure 3. On-State Characteristics



**Figure 4. Thermal Response** 



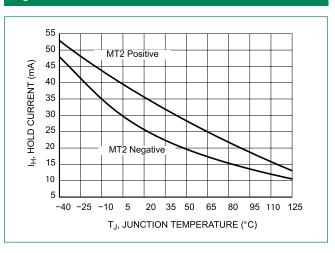
I<sub>T(RMS)</sub>, ON-STATE CURRENT (A)

90°

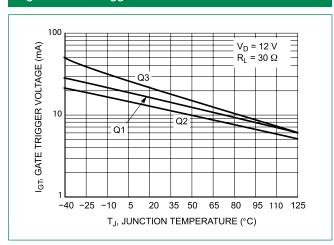
60°

: 30°

Figure 5. Hold Current Variation



## Figure 6. Gate Trigger Current Variation



**Thyristors** 

Figure 7. Gate Trigger Voltage Variation

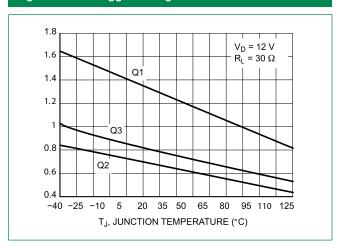


Figure 8. Critical Rate of Rise of Off-State Voltage (Exponential Waveform)

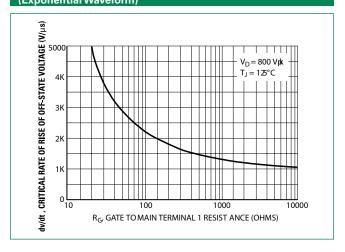
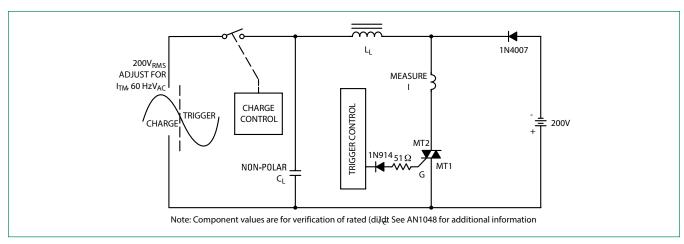
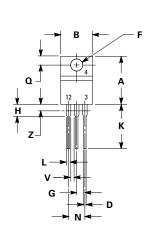


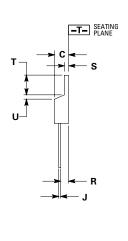
Figure 9. Simplified Test Circuit to Measure the Critical Rate of Rise of Commutating Current (di/dt)



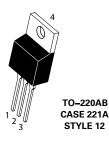
Note: Component values are for verification of rated (di/dt)c. See AN1048 for additional information

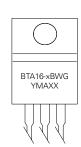
#### **Dimensions**





## **Part Marking System**





- x =6 or 8 Y =Year
- Y =Year M =Month
- A =Assembly Site
- XX =Lot Serial Code
- G =Pb-Free Package

D:	Inches		Millin	eters	
Dim	Min	Max	Min	Max	
Α	0.590	0.620	14.99	15.75	
В	0.380	0.420	9.65	10.67	
С	0.178	0.188	4.52	4.78	
D	0.025	0.035	0.64	0.89	
F	0.142	0.147	3.61	3.73	
G	0.095	0.105	2.41	2.67	
Н	0.110	0.130	2.79	3.30	
J	0.018	0.024	0.46	0.61	
K	0.540	0.575	13.72	14.61	
L	0.060	0.075	1.52	1.91	
N	0.195	0.205	4.95	5.21	
Q	0.105	0.115	2.67	2.92	
R	0.085	0.095	2.16	2.41	
s	0.045	0.060	1.14	1.52	
Т	0.235	0.255	5.97	6.47	
U	0.000	0.050	0.00	1.27	
V	0.045		1.15		
Z	_	0.080	_	2.04	

Pin Assignment				
1	Main Terminal 1			
2	Main Terminal 2			
3	Gate			
4	No Connection			

Ordering Information					
Device	Package	Shipping			
BTA16-600BW3G	TO-220AB (Pb-Free)	500 Units / Rail			
BTA16-800BW3G	TO-220AB (Pb-Free)	500 Units / Rail			

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<sup>1.</sup> DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

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